

<b>Notice of References Cited</b>	Application/Control No. 09/920,984	Applicant(s)/Patent Under Reexamination MIYANO ET AL.	
	Examiner Quynh H Nguyen	Art Unit 2642	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,529,745	03-2003	Fukagawa et al.	455/562.1
	B	US-6,795,424	09-2004	Kapoor et al.	370/343
	C	US-			
	D	US-			
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	K	US-			
	L	US-			
	M	US-			

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

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